

QSFCT138T, 238T



**High Speed CMOS
1-of-8 Decoders**

QS54/74FCT138T
QS54/74FCT238T

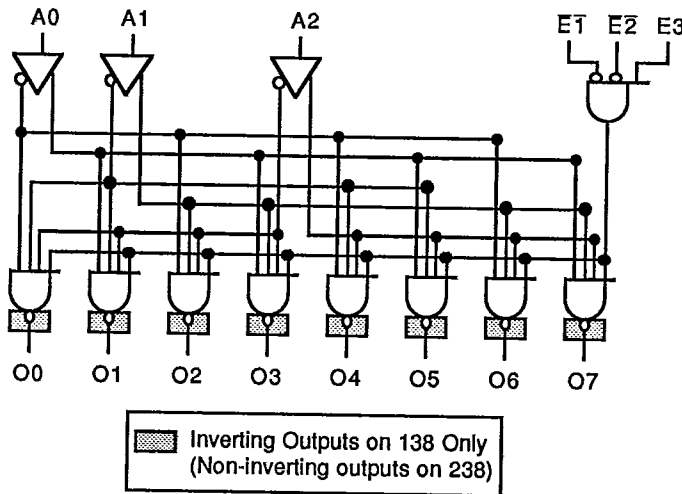
FEATURES/BENEFITS

- QSFCT138A faster than 74F
- I_{OL}=48 mA COM, 32 mA MIL
- TTL-compatible input and output levels
- Mil product compliant with MIL-STD 883, Class B
- QSFCT238T has positive active outputs
- CMOS power levels < 7.5 mW static
- Available in DIP, ZIP, SOIC, QSOP, LCC
- JEDEC standard pinouts

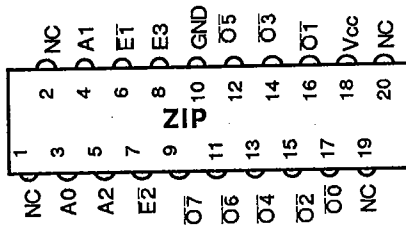
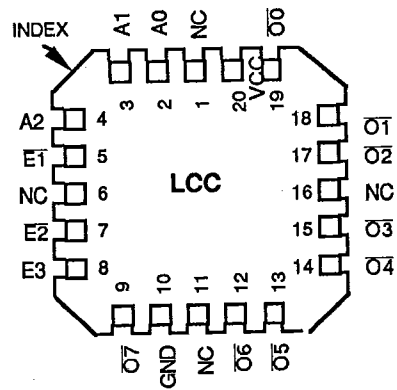
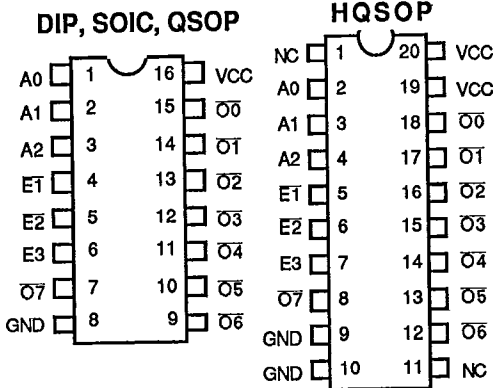
DESCRIPTION

The QSFCT138T and QSFCT238T are high speed CMOS TTL-compatible high speed binary decoders. The QSFCT138T has negative active outputs, and the QSFCT238T has positive active outputs. The high output current I_{OL} and I_{OH} drive high capacitance loads. All inputs have clamp diodes for undershoot noise suppression. All outputs have ground bounce suppression (see QSI Application Note AN-001), and outputs will not load an active bus when V_{CC} is removed from the device.

FUNCTIONAL BLOCK DIAGRAM



PIN CONFIGURATIONS



| Name | I/O | Description |
|------|-----|----------------|
| Ai | I | Select Inputs |
| Oi | O | Decode Outputs |
| Ei | I | Enable |

| Output State | Output Level | |
|--------------|--------------|-----|
| | 138 | 238 |
| 0 | H | L |
| 1 | L | H |

| Enable | | | Select | | | Output | | | | | | | Function | |
|--------|----|----|--------|----|----|--------|----|----|----|----|----|----|----------|----------|
| ET | E2 | E3 | A2 | A1 | A0 | O7 | O6 | O5 | O4 | O3 | O2 | O1 | | O0 |
| H | X | X | X | X | X | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | Disable |
| X | H | X | X | X | X | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | Disable |
| X | X | L | X | X | X | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | Disable |
| L | L | H | L | L | L | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | A2-0 = 0 |
| L | L | H | L | L | H | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | A2-0 = 1 |
| L | L | H | L | H | L | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | A2-0 = 2 |
| L | L | H | L | H | H | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | A2-0 = 3 |
| L | L | H | H | L | L | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 | A2-0 = 4 |
| L | L | H | H | L | H | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0 | A2-0 = 5 |
| L | L | H | H | H | L | 0 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | A2-0 = 6 |
| L | L | H | H | H | H | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | A2-0 = 7 |

QSFCT138T, 238T

ABSOLUTE MAXIMUM RATINGS

Supply Voltage to Ground..... -0.5V to +7.0V
 DC Output Voltage V_O -0.5V to 7.0V
 DC Input Voltage V_I -0.5V to 7.0V
 AC Input Voltage (for a pulse width ≤ 20 ns)..... -3.0V
 DC Input Diode Current with $V_I < 0$ -20 mA
 DC Output Diode Current with $V_O < 0$ -50 mA
 DC Output Current Max. sink current/pin..... 120 mA
 Maximum Power Dissipation..... 0.5 watts
 T_{STG} Storage Temperature..... -65° to +165°C

CAPACITANCE

$T_A = 25^\circ\text{C}$, $f = 1\text{ MHz}$, $V_{in} = 0\text{V}$, $V_{out} = 0\text{V}$

| Pins | SOIC | QSOP | PDIP,LCC | ZIP | Unit |
|-----------|------|------|----------|-----|------|
| 1-3 | 4 | 4 | 5 | 7 | pF |
| 7,9-12 | 6 | 6 | 7 | 9 | pF |
| 4-6,13-15 | 8 | 8 | 9 | 10 | pF |

Note: Capacitance is characterized but not tested

4

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Commercial $T_A = 0^\circ\text{C}$ to 70°C , $V_{CC} = 5.0\text{V} \pm 5\%$

Military $T_A = -55^\circ\text{C}$ to 125°C , $V_{CC} = 5.0\text{V} \pm 10\%$

| Symbol | Parameter | Test Conditions | | Min | Typ (1) | Max | Unit |
|--------------------------|------------------------------------|---|-------------------------------|-----|---------|------|---------------|
| V_{ih} | Input High Voltage | Logic HIGH for All Inputs | | 2.0 | - | - | Volts |
| V_{il} | Input LOW Voltage | Logic LOW for All Inputs | | - | - | 0.8 | |
| ΔV_t | Input Hysterisis | $V_{th} - V_{tl}$ for All Inputs | | - | 0.2 | - | |
| $ i_{ih} $ $ i_{il} $ | Input Current Input HIGH or LOW | $V_{CC} = \text{MAX}$ | $0 \leq V_{in} < V_{CC}$ | - | - | 5 | μA |
| $ i_{oz} $ | Off State Output Current (Hi-Z) | $V_{CC} = \text{MAX}$, $0 \leq V_{in} \leq V_{CC}$ | | - | - | 5 | |
| i_{os} | Short Circuit Current | $V_{CC} = \text{MAX}$, $V_o = \text{GND}$ (2,3) | | -60 | - | -225 | mA |
| V_{ic} | Input Clamp Voltage | $V_{CC} = \text{MIN}$, $i_{in} = 18\text{ mA}$ (3) | | - | -0.7 | -1.2 | Volts |
| V_{oh} | Output HIGH Voltage | $V_{CC} = \text{MIN}$ | $i_{oh} = 12\text{ mA}$ (MIL) | 2.4 | - | - | Volts |
| | | | $i_{oh} = 15\text{ mA}$ (COM) | 2.4 | - | - | |
| V_{ol} | Output LOW Voltage | $V_{CC} = \text{MIN}$ | $i_{ol} = 32\text{ mA}$ (MIL) | - | - | 0.50 | |
| | | | $i_{ol} = 48\text{ mA}$ (COM) | - | - | 0.50 | |

Notes:

1. Typical values indicate $V_{CC} = 5.0\text{V}$ and $T_A = 25^\circ\text{C}$.
2. Not more than one output should be shorted and the duration is ≤ 1 second.
3. These parameters are guaranteed by design but not tested.

POWER SUPPLY CHARACTERISTICS

| Symbol | Parameter | Test Conditions (1) | Min | Max | Unit |
|------------------|-------------------------------------|--|-----|------|------------|
| I _{cc} | Quiescent Power Supply Current | V _{cc} = MAX, freq = 0 0V ≤ V _{in} ≤ 0.2V or V _{cc} - 0.2V ≤ V _{in} ≤ V _{cc} | - | 1.5 | mA |
| ΔI _{cc} | Supply Current per Input @ TTL HIGH | V _{cc} = MAX, V _{in} = 3.4 V, freq = 0 (2) | - | 2.0 | |
| Q _{ccd} | Supply Current per input per mHz | V _{cc} = MAX, Outputs open and enabled One bit toggling @ 50% duty cycle Other inputs at GND or V _{cc} (3,4) | - | 0.25 | mA/ MHz |

1. For conditions shown as MIN or MAX use the appropriate values specified under DC specifications.
2. Per TTL driven input (V_i = 3.4V)
3. For flipflops Q_{ccd} is measured by switching one of the data input pins so that the output changes every clock cycle. This is a measurement of device power consumption only and does not include power to drive load capacitance or tester capacitance. This parameter is guaranteed by design but not tested.
4. I_c can be computed using the above parameters as explained in the Technical Overview section.

SWITCHING CHARACTERISTICS OVER OPERATING RANGE

Commercial TA = 0° C to 70° C, V_{cc} = 5.0V ± 5% Military TA = -55° C to 125° C, V_{cc} = 5.0V ± 10%
 Cload = 50 pF, Rload = 500Ω unless otherwise noted

| Symbol | Description | Notes (1) | 138, 238 | | 138A 238A | | 138C 238C | | 138D 238D | | Unit ns |
|-------------------|---|--------------|----------|-----|--------------|-----|--------------|-----|--------------|-----|------------|
| | | | Min | Max | Min | Max | Min | Max | Min | Max | |
| t _{PHL} | Propagation Delay A _i to O _i | COM | 1.5 | 9 | 1.5 | 5.8 | 1.5 | 5.0 | 1.0 | 4.0 | |
| t _{PLH} | | MIL | 1.5 | 12 | 1.5 | 7.8 | 1.5 | 7.0 | | | |
| t _{PHLE} | Propagation Delay E _i to O _i | COM | 1.5 | 8 | 1.5 | 5.9 | 1.5 | 5.0 | 1.0 | 4.0 | |
| t _{PLHE} | | MIL | 1.5 | 12 | 1.5 | 8.0 | 1.5 | 7.0 | | | |

Notes:

- 1) Minimums guaranteed but not tested. See Test Circuit and Waveforms.